

# C3M0060065K

## Silicon Carbide Power MOSFET C3M™ MOSFET Technology

N-Channel Enhancement Mode

### Features

- 3<sup>rd</sup> Generation SiC MOSFET technology
- High blocking voltage with low on-resistance
- High speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Qrr)
- Halogen free, RoHS compliant

### Benefits

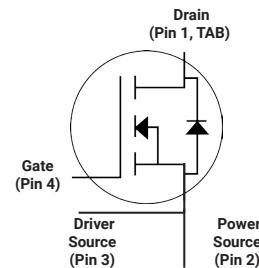
- Higher system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency
- Easy to parallel and simple to drive
- Enable new hard switching PFC topologies (Totem-Pole)

### Applications

- EV charging
- Server power supplies
- Solar PV inverters
- UPS
- DC/DC converters

$V_{DS}$	650 V
$I_D @ 25^\circ C$	37 A
$R_{DS(on)}$	60 mΩ

### Package



Part Number	Package	Marking
C3M0060065K	TO-247-4	C3M0060065K

### Maximum Ratings ( $T_c = 25^\circ C$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
$V_{DSmax}$	Drain - Source Voltage	650	V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
$V_{GSmax}$	Gate - Source Voltage (dynamic)	-8/+19	V	AC ( $f > 1 \text{ Hz}$ )	Note: 1
$V_{GSop}$	Gate - Source Voltage (static)	-4/+15	V	Static	Note: 2
$I_D$	Continuous Drain Current	37	A	$V_{GS} = 15 \text{ V}, T_c = 25^\circ \text{C}$	Fig. 19
		27		$V_{GS} = 15 \text{ V}, T_c = 100^\circ \text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	53	A	Pulse width $t_p$ limited by $T_{jmax}$	
$P_D$	Power Dissipation	150	W	$T_c = 25^\circ \text{C}, T_j = 175^\circ \text{C}$	Fig. 20
$T_j, T_{stg}$	Operating Junction and Storage Temperature	-40 to +175	°C		
$T_L$	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	
$M_d$	Mounting Torque	1 8.8	Nm lbf-in	M3 or 6-32 screw	

Note (1): When using MOSFET Body Diode  $V_{GSmax} = -4\text{V}/+19\text{V}$

Note (2): MOSFET can also safely operate at 0/+15 V

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	650			V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.8	2.3	3.6	V	$V_{DS} = V_{GS}, I_D = 5 \text{ mA}$	Fig. 11
			1.9		V	$V_{DS} = V_{GS}, I_D = 5 \text{ mA}, T_J = 175^\circ\text{C}$	
$I_{DSS}$	Zero Gate Voltage Drain Current		1	50	$\mu\text{A}$	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	
$I_{GSS}$	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$	
$R_{DS(\text{on})}$	Drain-Source On-State Resistance	42	60	79	$\text{m}\Omega$	$V_{GS} = 15 \text{ V}, I_D = 13.2 \text{ A}$	Fig. 4, 5,6
			80			$V_{GS} = 15 \text{ V}, I_D = 13.2 \text{ A}, T_J = 175^\circ\text{C}$	
$g_{fs}$	Transconductance		10		S	$V_{DS} = 20 \text{ V}, I_{DS} = 13.2 \text{ A}$	Fig. 7
			9			$V_{DS} = 20 \text{ V}, I_{DS} = 13.2 \text{ A}, T_J = 175^\circ\text{C}$	
$C_{iss}$	Input Capacitance		1020		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$	Fig. 17, 18
$C_{oss}$	Output Capacitance		80			$f = 1 \text{ MHz}$	
$C_{rss}$	Reverse Transfer Capacitance		9			$V_{AC} = 25 \text{ mV}$	
$C_{o(er)}$	Effective Output Capacitance (Energy Related)		95		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{ V to } 400 \text{ V}$	Note 3
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		132				
$E_{oss}$	$C_{oss}$ Stored Energy		15		$\mu\text{J}$	$V_{DS} = 600 \text{ V}, 1 \text{ MHz}$	Fig. 16
$E_{ON}$	Turn-On Switching Energy (Body Diode)		70		$\mu\text{J}$	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V/15 V}, I_D = 13.2 \text{ A}, R_{G(\text{ext})} = 2.5 \Omega, L = 135 \mu\text{H}, T_J = 175^\circ\text{C}$	Fig. 25
$E_{OFF}$	Turn Off Switching Energy (Body Diode)		5			FWD = Internal Body Diode of MOSFET	
$E_{ON}$	Turn-On Switching Energy (External SiC Diode)		67		$\mu\text{J}$	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V/15 V}, I_D = 13.2 \text{ A}, R_{G(\text{ext})} = 2.5 \Omega, L = 135 \mu\text{H}, T_J = 175^\circ\text{C}$	Fig. 25
$E_{OFF}$	Turn Off Switching Energy (External SiC Diode)		6			FWD = External SiC Diode	
$t_{d(on)}$	Turn-On Delay Time		8		ns	$V_{DD} = 400 \text{ V}, V_{GS} = -4 \text{ V/15 V}$ $I_D = 13.2 \text{ A}, R_{G(\text{ext})} = 2.5 \Omega, L = 135 \mu\text{H}$ Timing relative to $V_{DS}$ Inductive load	Fig. 26
$t_r$	Rise Time		11				
$t_{d(off)}$	Turn-Off Delay Time		17				
$t_f$	Fall Time		5				
$R_{G(int)}$	Internal Gate Resistance		3		$\Omega$	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$	
$Q_{gs}$	Gate to Source Charge		13		nC	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V/15 V}$ $I_D = 13.2 \text{ A}$ Per IEC60747-8-4 pg 21	Fig. 12
$Q_{gd}$	Gate to Drain Charge		17				
$Q_g$	Total Gate Charge		46				

Note (3):  $C_{o(en)}$ , a lumped capacitance that gives same stored energy as  $C_{oss}$  while  $V_{ds}$  is rising from 0 to 400V

$C_{o(tr)}$ , a lumped capacitance that gives same charging time as  $C_{oss}$  while  $V_{ds}$  is rising from 0 to 400V

**Reverse Diode Characteristics ( $T_c = 25^\circ\text{C}$  unless otherwise specified)**

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$V_{SD}$	Diode Forward Voltage	5.1		V	$V_{GS} = -4 \text{ V}, I_{SD} = 6.6 \text{ A}, T_J = 25^\circ\text{C}$	Fig. 8, 9, 10
		4.8		V	$V_{GS} = -4 \text{ V}, I_{SD} = 6.6 \text{ A}, T_J = 175^\circ\text{C}$	
$I_S$	Continuous Diode Forward Current		23	A	$V_{GS} = -4 \text{ V}, T_c = 25^\circ\text{C}$	Note 1
$I_{S,pulse}$	Diode pulse Current		53	A	$V_{GS} = -4 \text{ V}$ , pulse width $t_p$ limited by $T_{jmax}$	Note 1
$t_{rr}$	Reverse Recover time	11		ns	$V_{GS} = -4 \text{ V}, I_{SD} = 13.2 \text{ A}, V_R = 400 \text{ V}$ $dif/dt = 4500 \text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	Note 1
$Q_{rr}$	Reverse Recovery Charge	151		nC		
$I_{rrm}$	Peak Reverse Recovery Current	27		A	$V_{GS} = -4 \text{ V}, I_{SD} = 13.2 \text{ A}, V_R = 400 \text{ V}$ $dif/dt = 2400 \text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	Note 1
$t_{rr}$	Reverse Recover time	16		ns		
$Q_{rr}$	Reverse Recovery Charge	110		nC		
$I_{rrm}$	Peak Reverse Recovery Current	12		A		

**Thermal Characteristics**

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
$R_{0JC}$	Thermal Resistance from Junction to Case	0.99	°C/W		Fig. 21
$R_{0JA}$	Thermal Resistance From Junction to Ambient	40			

## Typical Performance

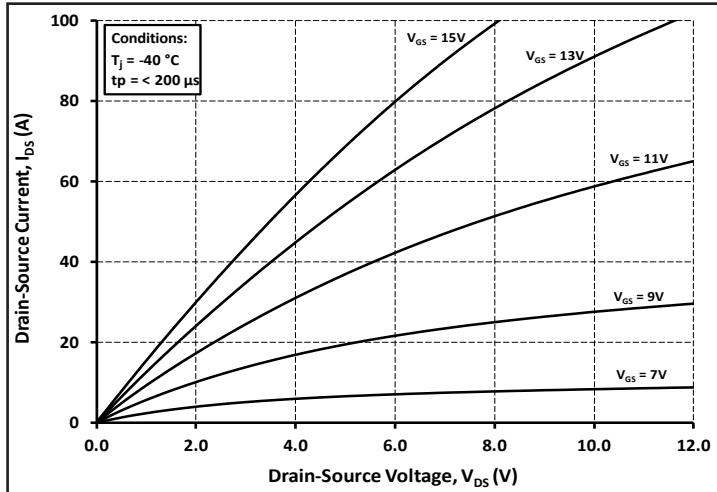


Figure 1. Output Characteristics  $T_J = -40^\circ\text{C}$

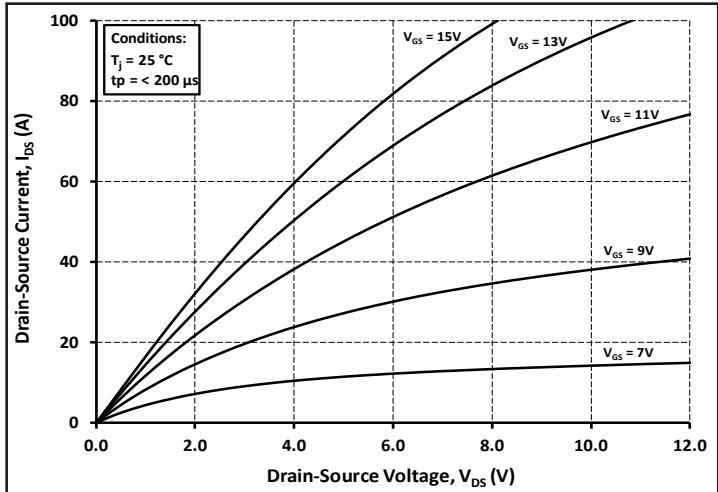


Figure 2. Output Characteristics  $T_J = 25^\circ\text{C}$

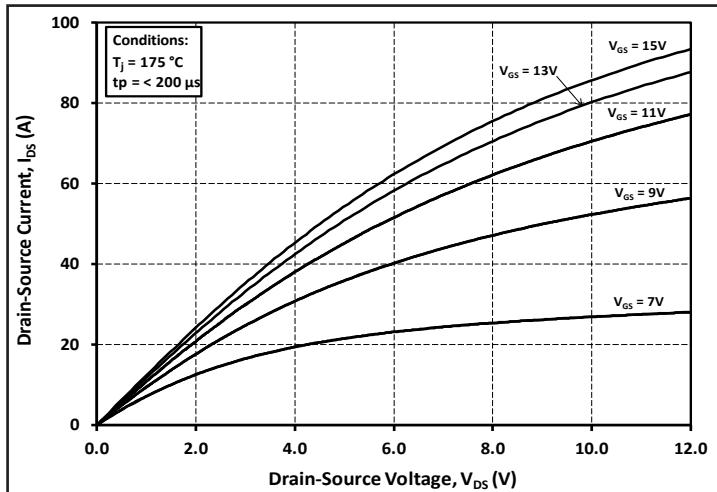


Figure 3. Output Characteristics  $T_J = 175^\circ\text{C}$

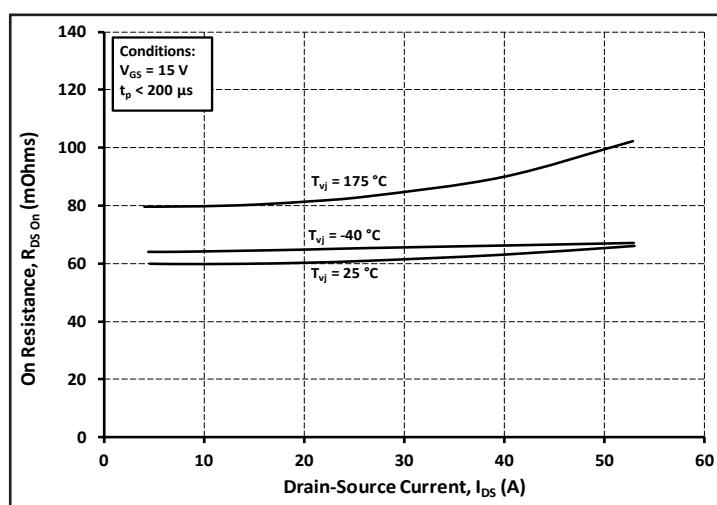
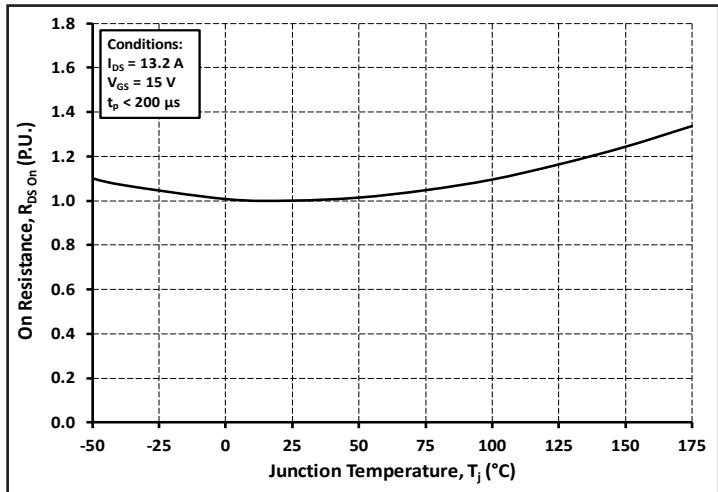
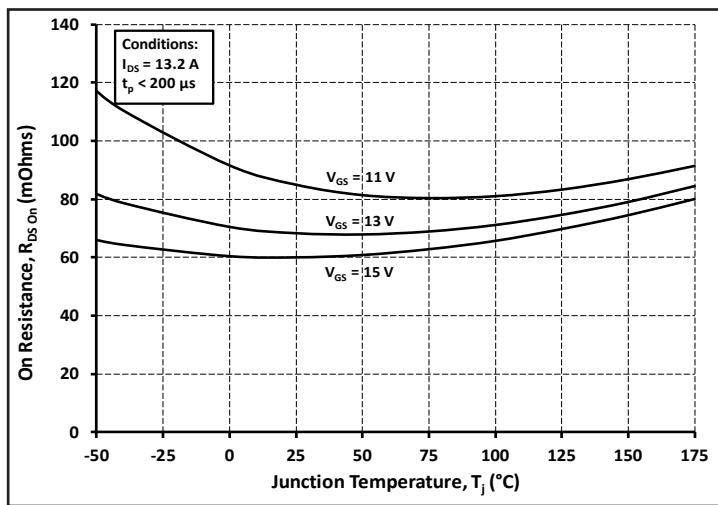


Figure 5. On-Resistance vs. Drain Current  
For Various Temperatures



## Typical Performance

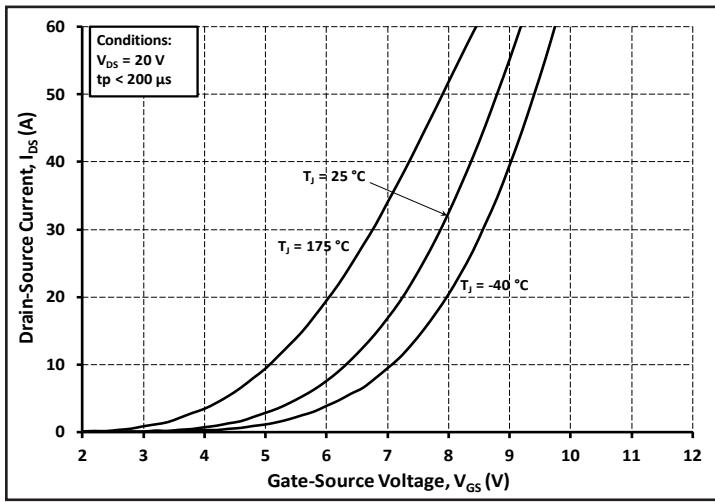


Figure 7. Transfer Characteristic for Various Junction Temperatures

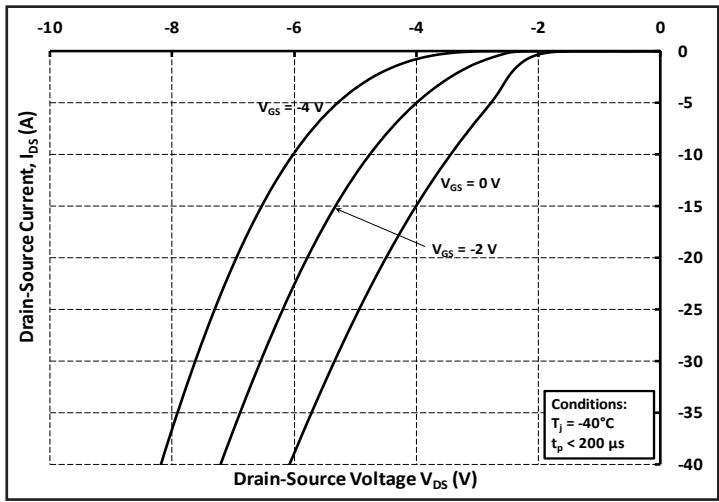


Figure 8. Body Diode Characteristic at  $-40^\circ\text{C}$

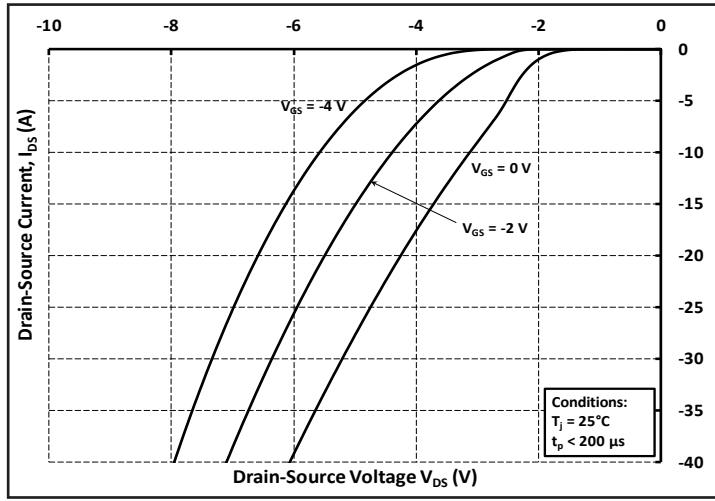


Figure 9. Body Diode Characteristic at  $25^\circ\text{C}$

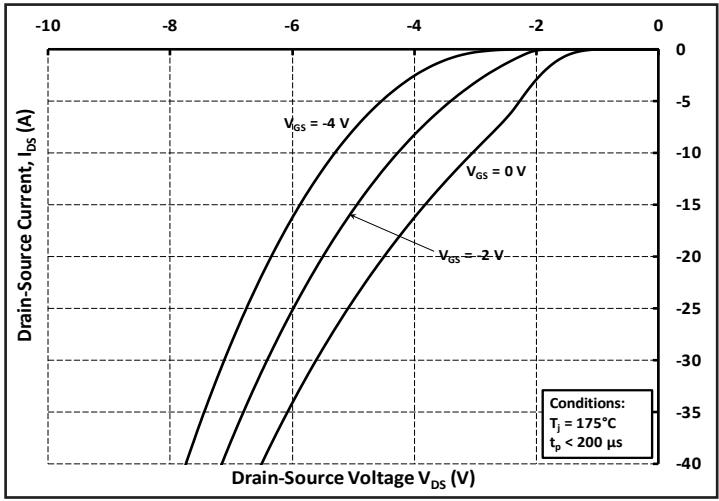


Figure 10. Body Diode Characteristic at  $175^\circ\text{C}$

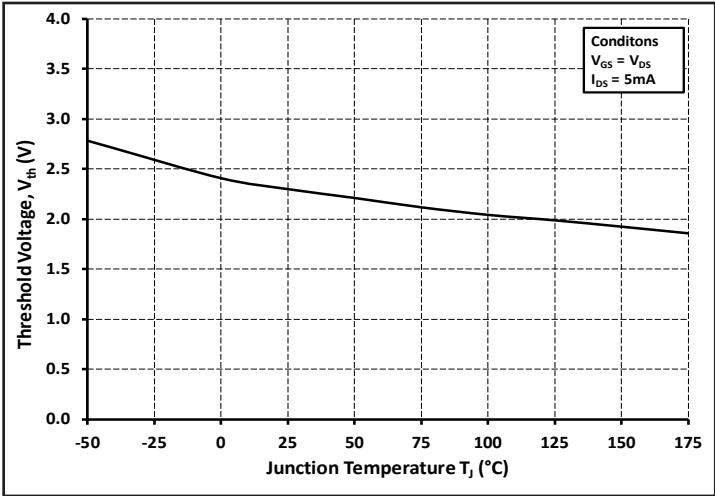


Figure 11. Threshold Voltage vs. Temperature

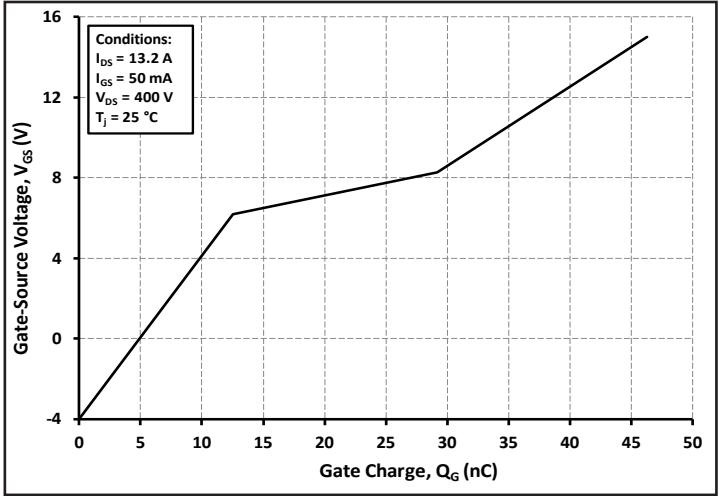


Figure 12. Gate Charge Characteristics

## Typical Performance

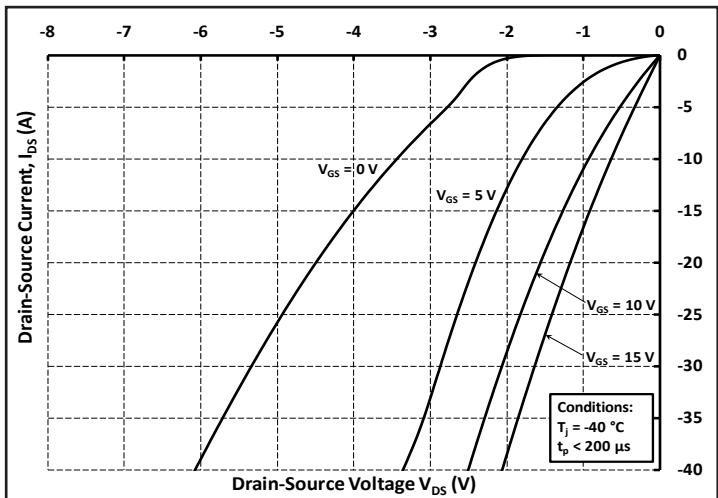


Figure 13. 3rd Quadrant Characteristic at  $-40^\circ\text{C}$

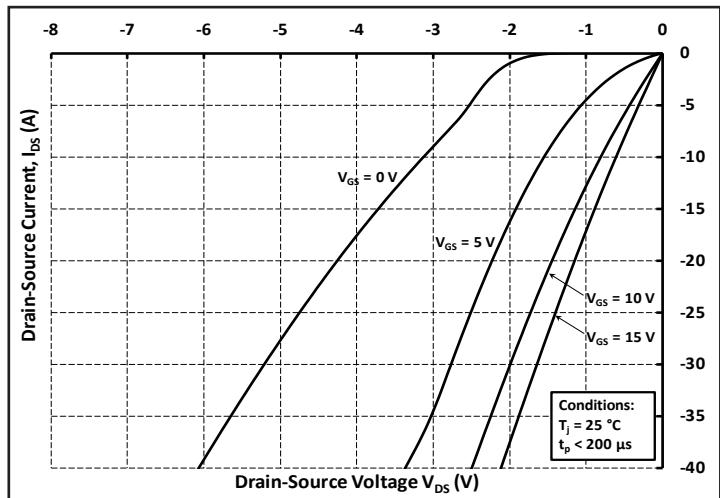


Figure 14. 3rd Quadrant Characteristic at  $25^\circ\text{C}$

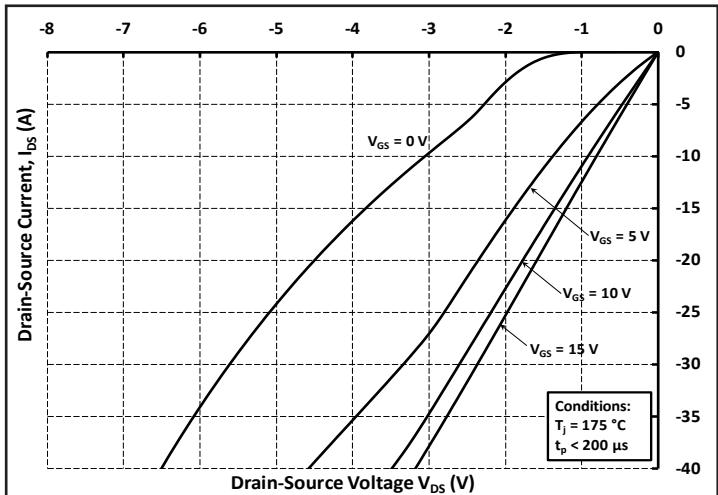


Figure 15. 3rd Quadrant Characteristic at  $175^\circ\text{C}$

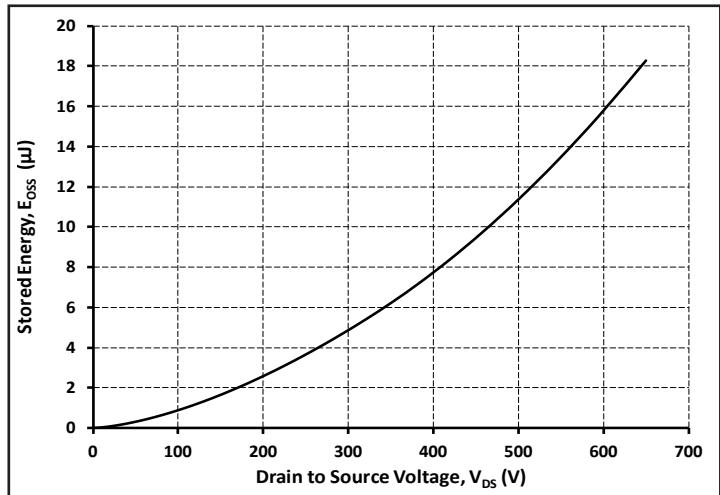


Figure 16. Output Capacitor Stored Energy

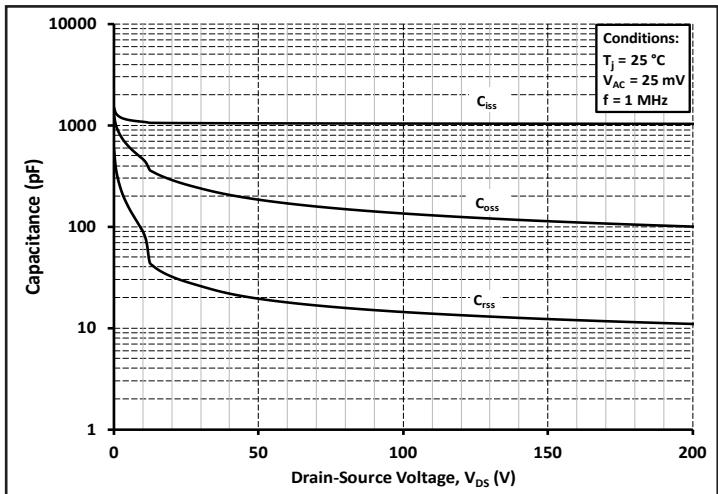


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

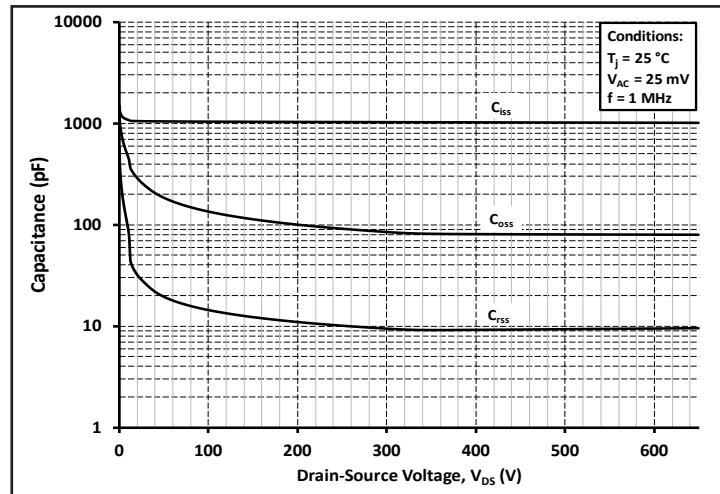
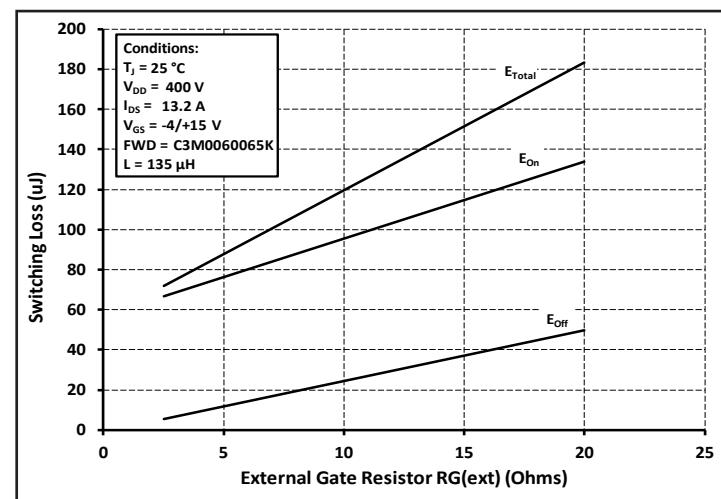
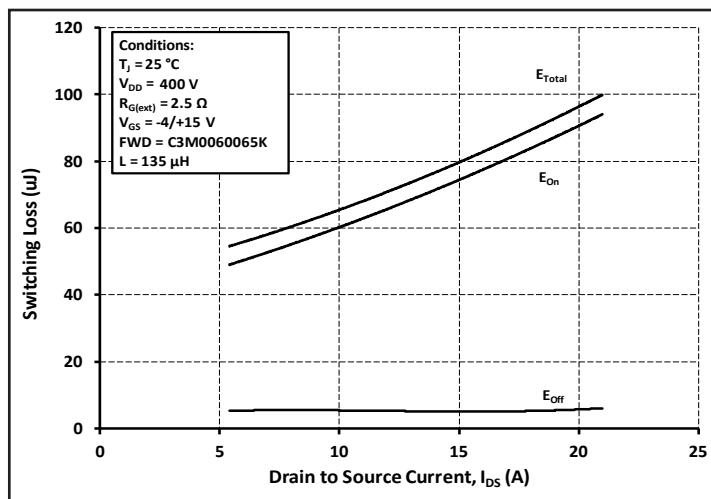
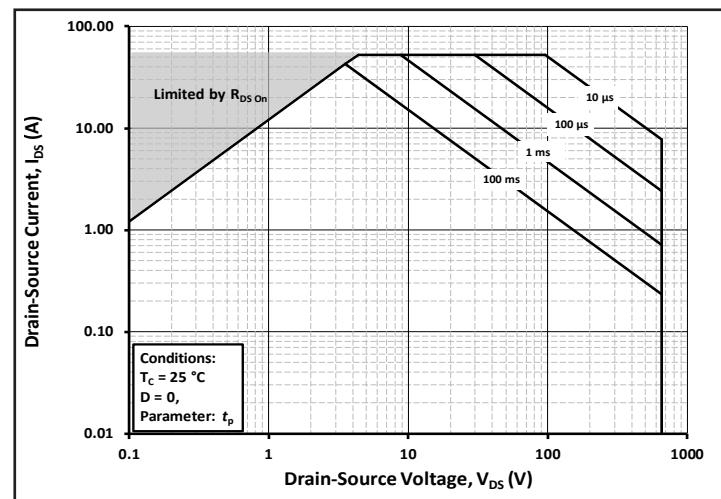
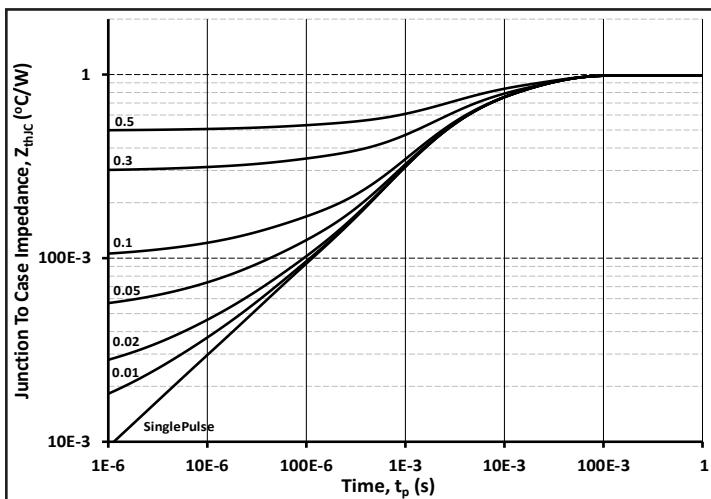
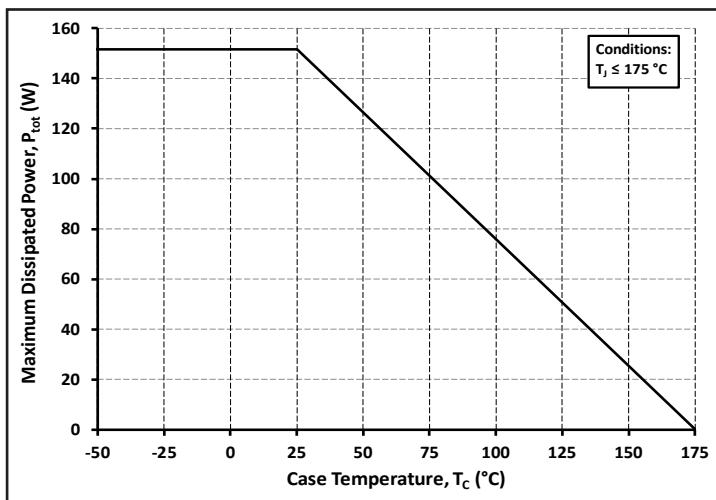
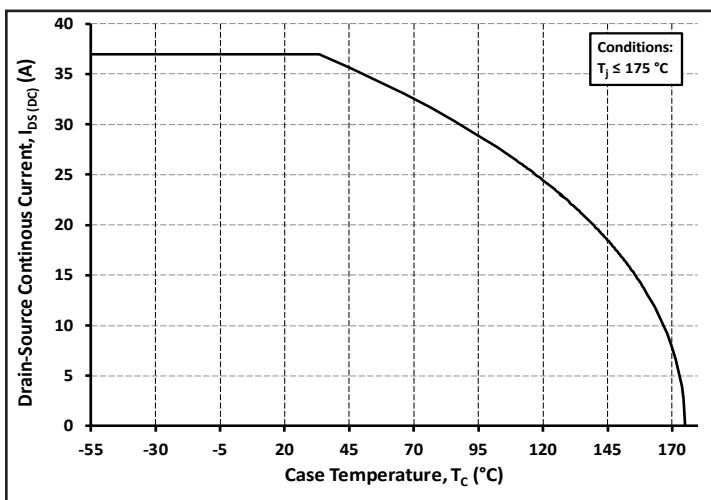


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650V)

## Typical Performance



## Typical Performance

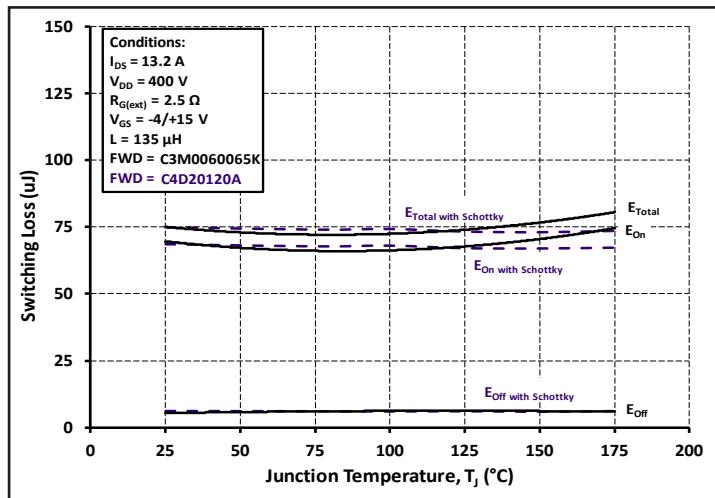


Figure 25. Clamped Inductive Switching Energy vs.  
Temperature

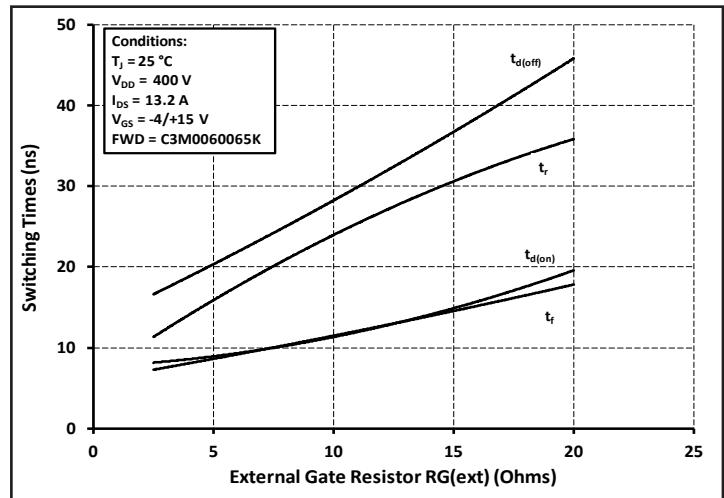


Figure 26. Switching Times vs.  $R_{G(ext)}$

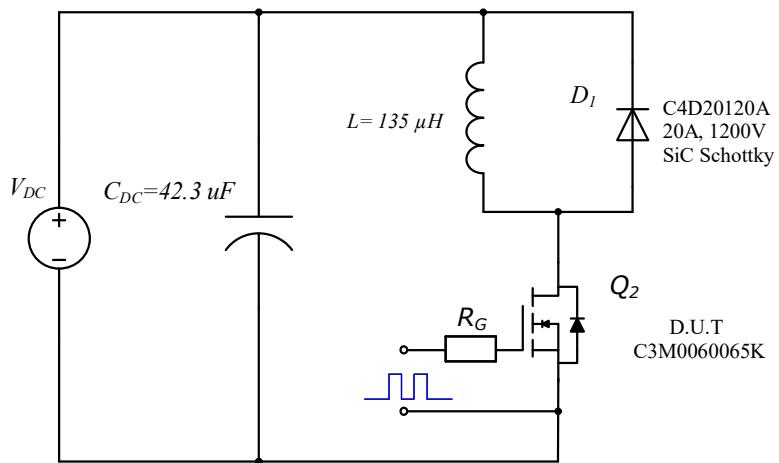


Figure 27. Clamped Inductive Switching  
Waveform Test Circuit

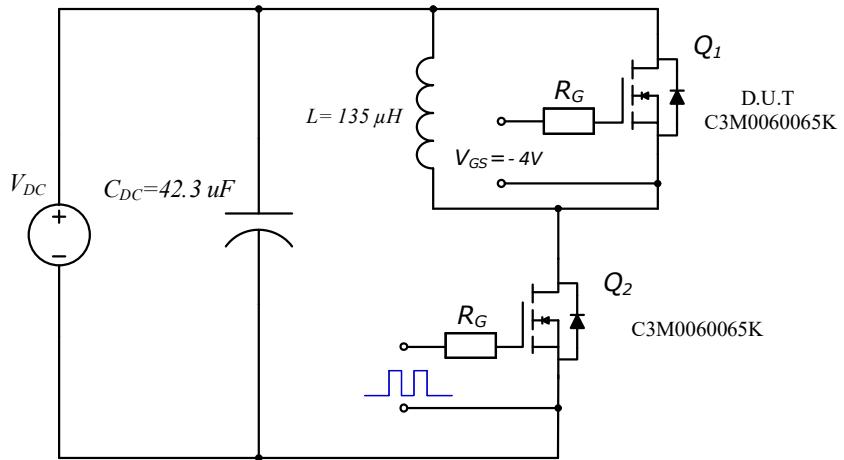
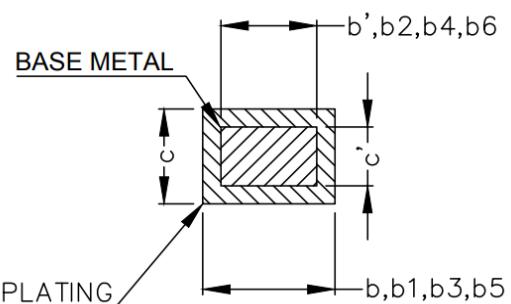
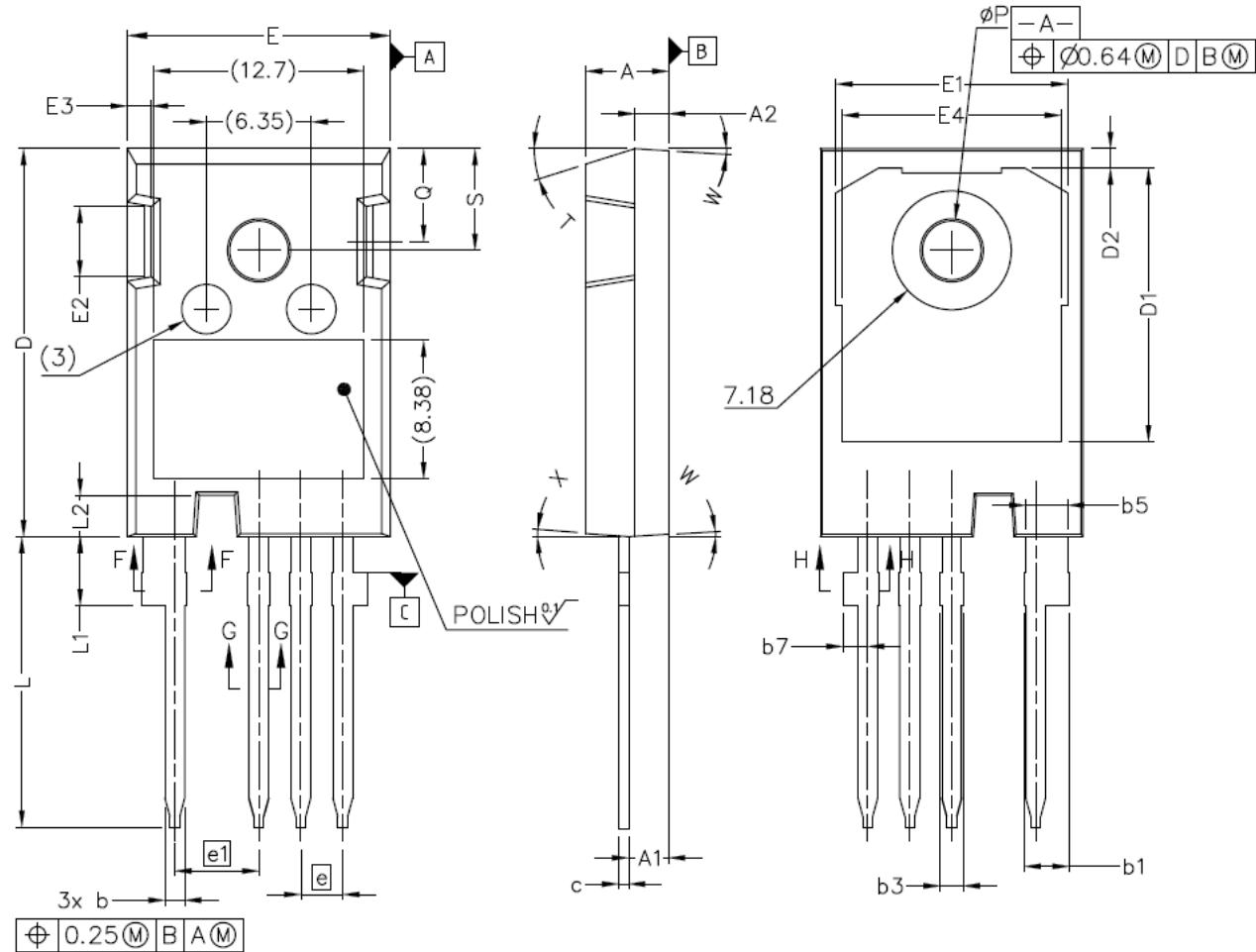


Figure 28. Body Diode Recovery Test Circuit

Note (4): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

## Package Dimensions

Package TO-247-4L



SECTION "F-F", "G-G" AND "H-H"  
SCALE: NONE

## Package Dimensions

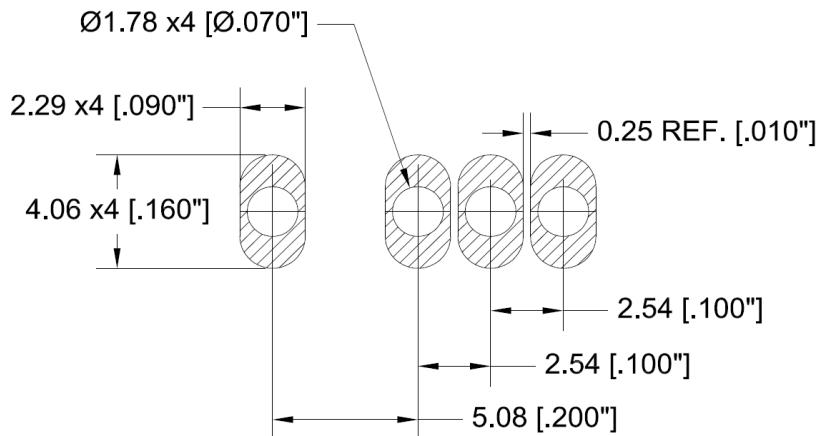
### Package TO-247-4L

NOTE ;

1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT
2. DIMENSIONING & TOLERANCEING CONFIRM TO ASME Y14.5M-1994.
3. ALL DIMENSIONS ARE IN MILLIMETERS.  
ANGLES ARE IN DEGREES.
4. 'N' IS THE NUMBER OF TERMINAL POSITIONS

SYM	MILLIMETERS	
	MIN	MAX
A	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b`	1.07	1.28
b	1.07	1.33
b1	2.39	2.94
b2	2.39	2.84
b3	1.07	1.60
b4	1.07	1.50
b5	2.39	2.69
b6	2.39	2.64
b7	1.30	1.70
c`	0.55	0.65
c	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13

SYM	MILLIMETERS	
	MIN	MAX
E1	13.10	14.15
E2	3.68	5.10
E3	1.00	1.90
E4	12.38	13.43
e	2.54 BSC	
e1	5.08 BSC	
N*	4	
L	17.31	17.82
L1	3.97	4.37
L2	2.35	2.65
Ø P	3.51	3.65
Q	5.49	6.00
S	6.04	6.30
T	17.5° REF.	
W	3.5° REF.	
X	4° REF.	



## Notes

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- **RoHS Compliance**

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of [www.cree.com](http://www.cree.com).

- **REACH Compliance**

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a Cree representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

- This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.

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- **SPICE Models:** <http://wolfspeed.com/power/tools-and-support>
- **SiC MOSFET Isolated Gate Driver reference design:** <http://wolfspeed.com/power/tools-and-support>
- **SiC MOSFET Evaluation Board:** <http://wolfspeed.com/power/tools-and-support>

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